


Search Notes 	Application/Control No. 10057886	Applicant(s)/Patent Under Reexamination HIDESAWA, SHIGERU
	Examiner D'alencourt, Yves	Art Unit 2157

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
WEST (updated text search)	10/13/2007	YD
IEEE Xplore	10/13/2007	YD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
WEST (updated text search 709/229)		10/13/2007	YD